



V-TAC EXPORTS LIMITED

EMC TEST REPORT

Prepared For:	V-TAC EXPORTS LIMITED ROOM NO.301, KAM ON BUILDING 176A QUEENS ROAD CENTRAL, CERNTRAL, HONGKONG
Product Name:	Wifi smart device
Trade Mark:	N/A
Model:	VT-5003, TV-5004, VT-5005, VT-5013, VT-5003-BS, VT-5004-BS, VT-5005-BS
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### TEST REPORT DECLARATION

Applicant:	V-TAC EXPORTS LIMITED
Address:	ROOM NO.301, KAM ON BUILDING 176A QUEENS ROAD CENTRAL, CERNTRAL, HONGKONG
Manufacturer:	V-TAC EXPORTS LIMITED
Address:	ROOM NO.301, KAM ON BUILDING 176A QUEENS ROAD CENTRAL, CERNTRAL, HONGKONG
EUT Description:	Wifi smart device
Model Number:	VT-5003, TV-5004, VT-5005, VT-5013, VT-5003-BS, VT-5004-BS, VT-5005-BS

Test Standards:

- ETSI EN301 489-1 V2.2.0 (2017-03)
- ETSI EN301 489-17 V3.2.0 (2017-03)

The EUT described above is tested by Shenzhen STL Testing Technology Co., Ltd. EMC Laboratory to determine the maximum emissions from the EUT and ensure the EUT to be compliance with the immunity requirements of the EUT. Shenzhen STL Testing Technology Co., Ltd. EMC Laboratory is assumed full responsibility for the accuracy of the test results. Also, this report shows that the EUT technically complies with the 2014/53/EU directive and its amendment requirements.

The test report is valid for above tested sample only and shall not be reproduced in part without written approval of the laboratory.

Prepared by: *Kahn Yang*  
Kahn yang/Editor

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Sherwin Qian/Supervisor

Approved & Authorized Signer: *liuze*  
Liuze/Manager



## 1. TEST RESULTS SUMMARY

Test Results Summary

Test Items	Test Results
Conducted Disturbance	Pass
Radiated Emission	Pass
Harmonic Current	N/A
Voltage Fluctuation and Flicker	Pass
Electrostatic Discharge Immunity	Pass
Radiated Electromagnetic Fields Immunity	Pass
Electric Fast Transient Burst Immunity	Pass
Surge Immunity	Pass
Conducted Immunity	Pass
Voltage dips and interruptions Immunity	Pass

N/A\* Please refer to Applicability overview tables in sections 7.1 and 7.2 of EN 301 489-1 requirements.



## 2. GENERAL INFORMATION

### 2.1. Report information

- 2.1.1. This report is not a certificate of quality; it only applies to the sample of the specific product/equipment given at the time of its testing. The results are not used to indicate or imply that they are application to the similar items. In addition, such results must not be used to indicate or imply that STL approves recommends or endorses the manufacture, supplier or use of such product/equipment, or that STL in any way guarantees the later performance of the product/equipment.
- 2.1.2. The sample/s mentioned in this report is/are supplied by Applicant, STL therefore assumes no responsibility for the accuracy of information on the brand name, model number, origin of manufacture or any information supplied.
- 2.1.3. Additional copies of the report are available to the Applicant at an additional fee. No third part can obtain a copy of this report through STL, unless the applicant has authorized STL in writing to do so.

### 2.2. Measurement Uncertainty

The reported uncertainty of measurement  $y \pm U$ , where expanded uncertainty  $U$  is based on a standard uncertainty multiplied by a coverage factor of  $k=2$ , providing a level of confidence of approximately 95 %.

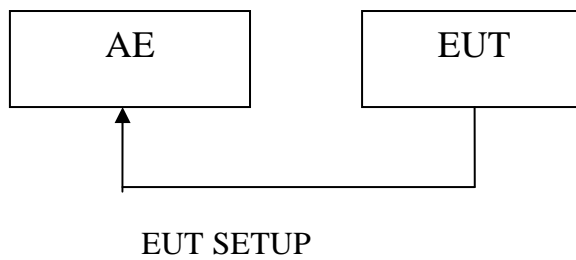
Test	Parameters	Expanded Uncertainty ( $U_{Lab}$ )	Expanded Uncertainty ( $U_{Cispr}$ )
Conducted Emission	Level Accuracy: 9kHz~150kHz 150kHz to 30MHz	$\pm 3.42$ dB $\pm 3.42$ dB	$\pm 4.0$ dB $\pm 3.6$ dB
Radiated Emission	Level Accuracy: 9kHz to 30 MHz	$\pm 4.60$ dB	N/A
Radiated Emission	Level Accuracy: 30MHz to 1000 MHz	$\pm 4.40$ dB	$\pm 5.2$ dB
Radiated Emission	Level Accuracy: Above 1000MHz	$\pm 4.20$ dB	N/A
Mains Harmonic	Voltage	$\pm 3.11\%$	N/A
Voltage Fluctuations & Flicker	Voltage	$\pm 3.25\%$	N/A

### 3. PRODUCT DESCRIPTION

#### 3.1. EUT Description

Description	:	Wifi smart device
Applicant	:	V-TAC EXPORTS LIMITED
Model Number	:	VT-5003
Operation Frequency	:	WIFI: 2.412-2.472GHz (802.11b/g/n)

#### 3.2. Block Diagram of EUT Configuration



#### 3.3. Support Equipment List

Ancillary Equipment				
Name	Model No	S/N	Manufacturer	Used
LCD	U2414Hb	/	DELL	NO
Wireless Router	TL-WR742N	/	TP-LINK	NO

#### 3.4. Operating Condition of EUT

Test mode 1: *Running*

#### 3.5. Test Conditions

Temperature: 23-26°C

Relative Humidity: 50-60 %

#### 3.6. Modifications

No modification was made.



### 3.7. Abbreviations

AC	Alternating Current
AMN	Artificial Mains Network
DC	Direct Current
EM	ElectroMagnetic
EMC	ElectroMagnetic Compatibility
EUT	Equipment Under Test
IF	Intermediate Frequency
RF	Radio Frequency
rms	root mean square
EMI	Electromagnetic Interference
EMS	Electromagnetic Susceptibility

### 3.8. Performance Criterion

**Criterion A:** The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended.

**Criterion B:** After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended.

**Criterion C:** Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions.



#### 4. TEST EQUIPMENT USED

##### 4.1. Conducted Emission Measurement

Item	Equipment	Manufacturer	Model No.	Serial No.	Calibrated until
1	AMN	SCHWARZBECK	NNLK8121	8121370	2019.9.9
2	AMN	ETS	3810/2	00020199	2019.9.9
3	EMI TEST RECEIVER	ROHDE&SCHWARZ	ESCI	101210	2019.9.9
4	AAN	TESEQ	T8-Cat6	38888	2019.9.9

##### 4.2. Radiated Emission Measurement

Item	Equipment	Manufacturer	Model No.	Serial No.	Calibrated until
1	Horn Antenna	Sunol	DRH-118	A101415	2019.9.29
2	Broadband Hybrid Antenna	Sunol	JB1 Antenna	A090215	2019.9.29
3	Amplifier	HP	8449B	3008A00160	2019.9.9
4	Amplifier	HP	8447D	2944A07999	2019.9.9
5	EMI TEST RECEIVER	ROHDE&SCHWARZ	ESR3	101891	2019.9.9
6	MXA Signal Analyzer	Keysight	N9020A	MY51110104	2019.9.9
7	Biconical antenna	Schwarzbeck	VHA 9103	91032360	2019.9.8
8	Biconical antenna	Schwarzbeck	VHA 9103	91032361	2019.9.8
9	Broadband Hybrid Antenna	Schwarzbeck	VULB9163	VULB9163#958	2019.9.8
10	Horn Antenna	Schwarzbeck	BBHA9120D	9120D-1680	2019.11.12
11	Active Receive Loop Antenna	Schwarzbeck	FMZB 1919B	00023	2019.11.02
12	Loop Antenna	Beijing daze Technology	ZN30401	13015	2019.9.9
13	EM CAMLP	SCHWARZBECK	MDS21	03350	2019.9.12
14	Horn Antenna	Schwarzbeck	BBHA 9170	BBHA9170651	2019.9.14
15	Microwave Broadband Preamplifier	Schwarzbeck	BBV 9721	100472	2019.10.24

##### 4.3. Harmonic / Flicker Measurement

Item	Equipment	Manufacturer	Model No.	Serial No.	Calibrated until
1	Power Analyzer	California Instrumnets	PACS-1	X71719	2019.9.28
2	AC Power Source	California Instrumnets	5001ix	HK53570	2019.9.9

##### 4.4. Electrostatic Discharge Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Calibrated until
1	ESD Simulator	EM TEST	ESD30C/P30	1202-17	2019.9.9

##### 4.5. Surge Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Calibrated until
1	Surge Generator	Shanghai Lioncel	LSG-506S	LSG506S0160601	2019.9.7
2	CDN	Shanghai Lioncel	CDN-532S	CDN532S0160601	2019.9.7



## 4.6. Electrical Fast Transient/Burst Immunity Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Calibrated until
1	EFT/B Generator	Shanghai Lioncel	EFT-404S	EFT404S0160601	2019.9.7

## 4.7. Power-frequency magnetic fields Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Calibrated until
1	Magnetic Field Test System	Shanghai Lioncel	PMF801C-T	PMF801C-T	2019.9.9

## 4.8. Voltage dips and interruptions Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Calibrated until
1	AC Power Source	California Instrumnets	5001ix	HK53570	2019.9.9

## 5. CONDUCTED DISTURBANCE TEST

### 5.1. Test Standard and Limit

#### 5.1.1. Test Standard

ETSI EN301 489-1 V2.2.0 (2017-03)

ETSI EN301 489-17 V3.2.0 (2017-03)

#### 5.1.2. Test Limit

Conducted Disturbance Test Limit

Frequency	Maximum RF Line Voltage (dB $\mu$ V)	
	Quasi-peak Level	Average Level
150kHz~500kHz	66 ~ 56 *	56 ~ 46 *
500kHz~5MHz	56	46
5MHz~30MHz	60	50

\* Decreasing linearly with logarithm of the frequency

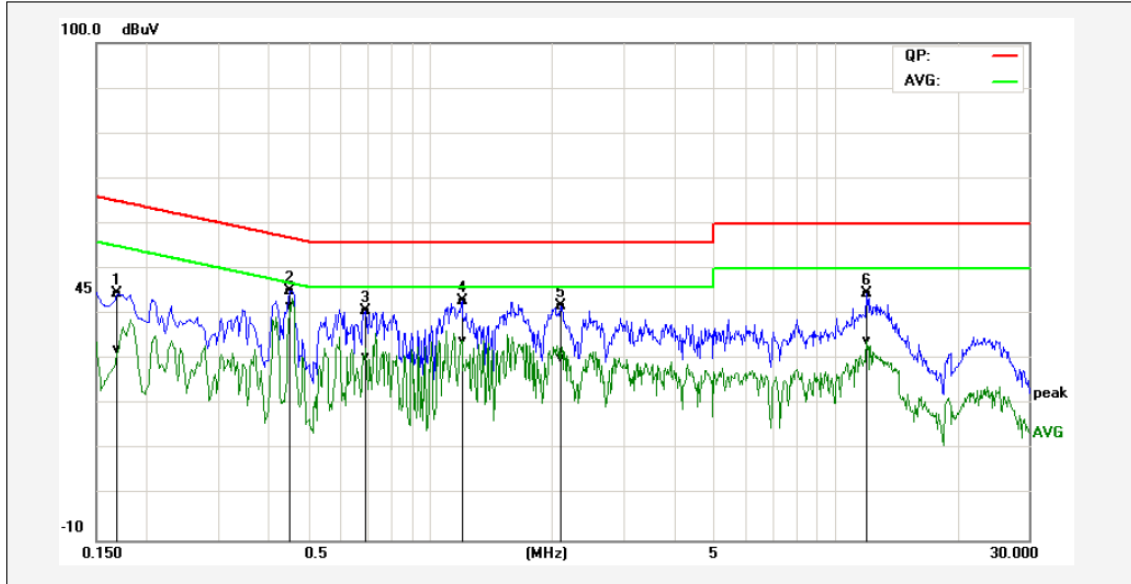
### 5.2. Test Procedure

The EUT is put on a table of non-conducting material that is 80cm high. The vertical conducting wall of shielding is located 40cm to the rear of the EUT. The power line of the EUT is connected to the AC mains through a Artificial Mains Network (A.M.N.). A EMI test receiver is used to test the emissions from both sides of AC line. The bandwidth of EMI test receiver is set at 9kHz.

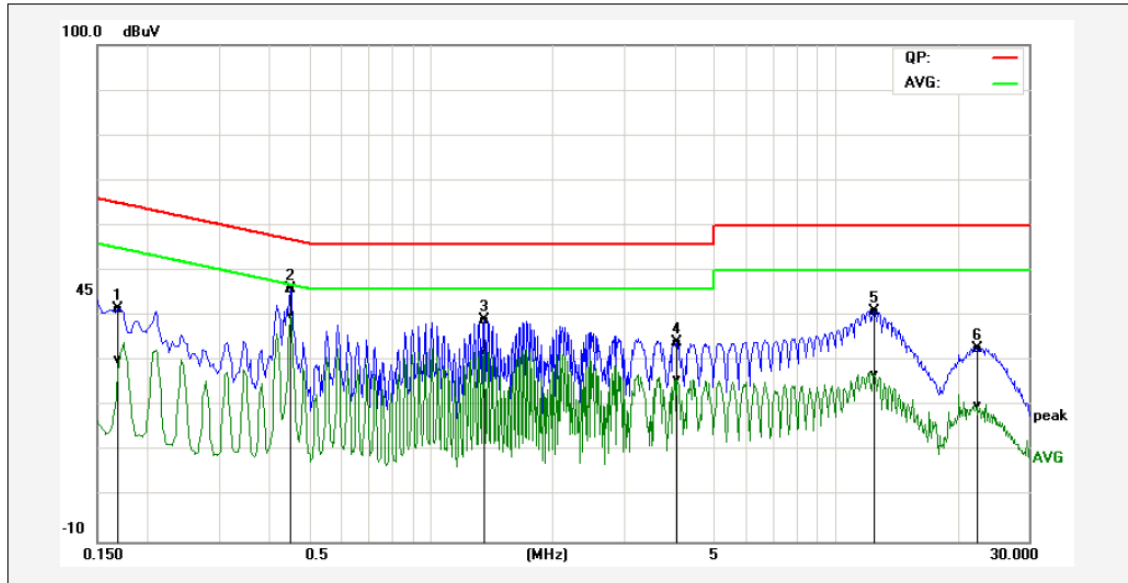
### 5.3. Test Arrangement

The arrangement of the equipment is installed to meet the standards and operating in a manner, which tends to maximize its emission characteristics in a normal application. The detailed information refers to test picture.

### 5.4. Test Data



No.	Frequency (MHz)	QuasiPeak reading (dBuV)	Average reading (dBuV)	Correction factor (dB)	QuasiPeak result (dBuV)	Average result (dBuV)	QuasiPeak limit (dBuV)	Average limit (dBuV)	QuasiPeak margin (dB)	Average margin (dB)	Remark
1P	0.1700	35.59	23.29	8.90	44.49	32.19	64.96	54.96	-20.47	-22.77	Pass
2*	0.4500	35.20	31.77	10.03	45.23	41.80	56.88	46.88	-11.65	-5.08	Pass
3P	0.6900	30.80	20.56	10.05	40.85	30.61	56.00	46.00	-15.15	-15.39	Pass
4P	1.1980	32.81	23.96	10.12	42.93	34.08	56.00	46.00	-13.07	-11.92	Pass
5P	2.1100	31.74	20.16	10.17	41.91	30.33	56.00	46.00	-14.09	-15.67	Pass
6P	11.9780	34.49	23.83	10.21	44.70	34.04	60.00	50.00	-15.30	-15.96	Pass



No.	Frequency (MHz)	QuasiPeak reading (dBuV)	Average reading (dBuV)	Correction factor (dB)	QuasiPeak result (dBuV)	Average result (dBuV)	QuasiPeak limit (dBuV)	Average limit (dBuV)	QuasiPeak margin (dB)	Average margin (dB)	Remark
1P	0.1700	32.78	21.34	8.90	41.68	30.24	64.96	54.96	-23.28	-24.72	Pass
2*	0.4500	35.85	30.21	10.03	45.88	40.24	56.88	46.88	-11.00	-6.64	Pass
3P	1.3540	28.80	22.10	10.16	38.96	32.26	56.00	46.00	-17.04	-13.74	Pass
4P	4.0580	24.02	15.79	10.13	34.15	25.92	56.00	46.00	-21.85	-20.08	Pass
5P	12.4580	30.94	16.93	10.19	41.13	27.12	60.00	50.00	-18.87	-22.88	Pass
6P	22.3100	22.19	9.32	10.67	32.86	19.99	60.00	50.00	-27.14	-30.01	Pass

## 6. RADIATED DISTURBANCE TEST

### 6.1. Test Standard and Limit

#### 6.1.1. Test Standard

ETSI EN301 489-1 V2.2.0 (2017-03)  
ETSI EN301 489-17 V3.2.0 (2017-03)

#### 6.1.2. Test Limit

Radiated Disturbance Test Limit (Class B)

Frequency	Limit (dB $\mu$ V/m)
	Quasi-peak Level
30MHz~230MHz	40
230MHz~1000MHz	47

\* The lower limit shall apply at the transition frequency.

\* The test distance is 3m.

Frequency range	Average Limit (dB $\mu$ V/m)	Peak Limit (dB $\mu$ V/m)
1000MHz~3000MHz	50	70
3000MHz~6000MHz	54	74

NOTE: The lower limit applies at the transition frequency

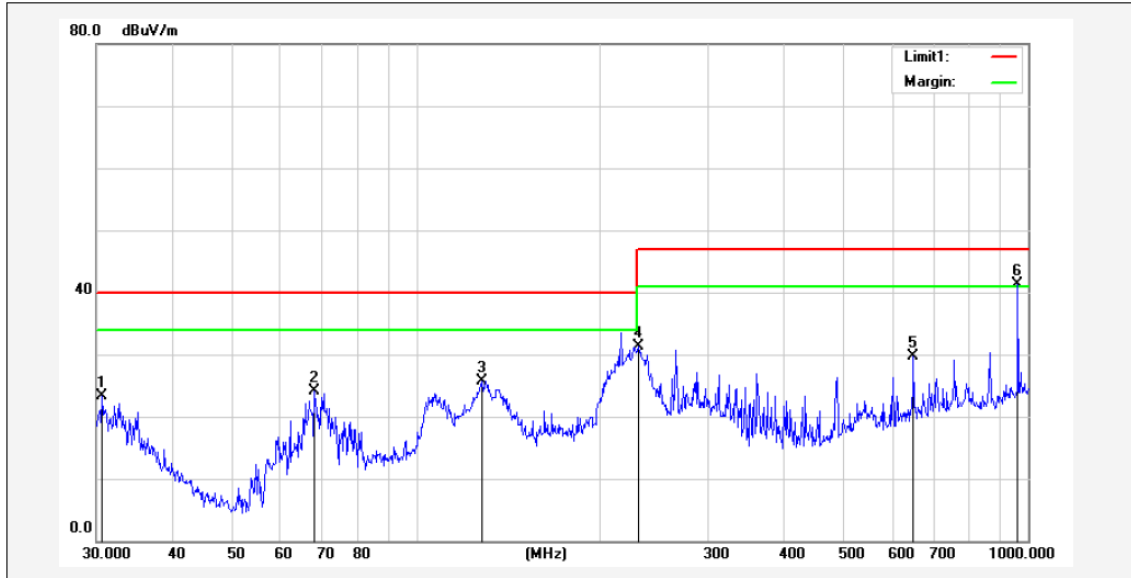
### 6.2. Test Procedure

The EUT is placed on a turntable, which is 0.8 meter above ground. The turntable can rotate 360 degrees to determine the position of the maximum emission level. EUT is set 3 meters away from the receiving antenna, which is mounted on an antenna tower. The antenna can move up and down between 1 to 4 meters to find out the maximum emission level. Broadband antenna is used as a receiving antenna. Both horizontal and vertical polarization of the antenna is set on test.

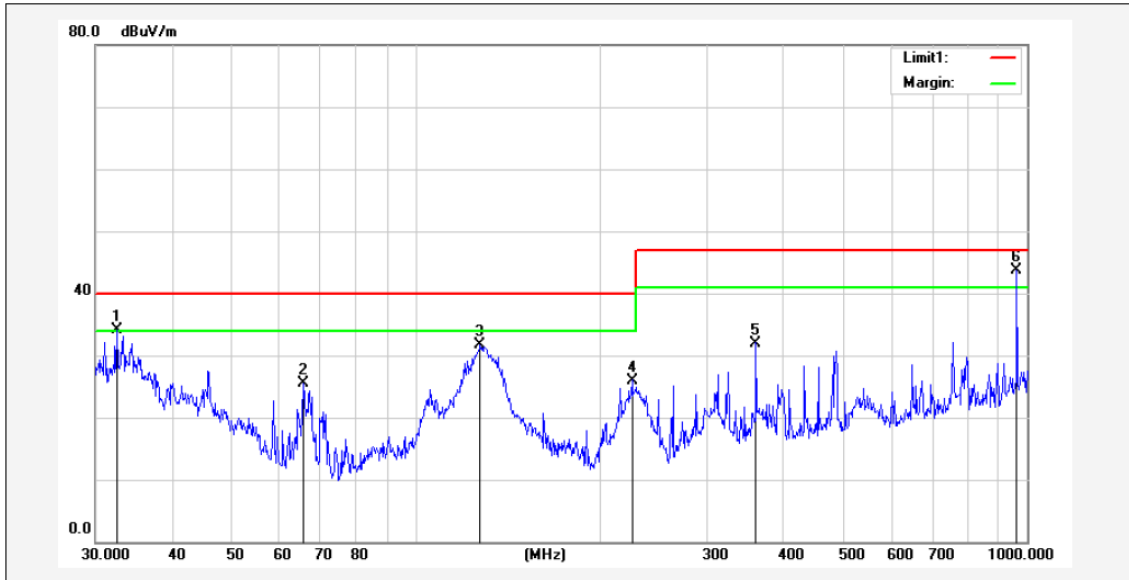
### 6.3. Test Arrangement

The arrangement of the equipment is installed to meet the standards and operating in a manner, which tends to maximize its emission characteristics in a normal application. The detailed information refers to test picture.

### 6.4. Test Data



No.	Frequency (MHz)	Reading (dBuV)	Correction factor(dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Degree (deg.)	Height (cm)	Remark
1	30.6379	30.32	-7.11	23.21	40.00	-16.79			peak
2	68.1514	45.81	-21.80	24.01	40.00	-15.99			peak
3	128.1130	39.94	-14.15	25.79	40.00	-14.21			peak
4	230.9068	46.55	-15.34	31.21	47.00	-15.79			peak
5	649.6597	36.20	-6.40	29.80	47.00	-17.20			peak
6*	962.1623	43.33	-2.09	41.24	47.00	-5.76			peak



No.	Frequency (MHz)	Reading (dBuV)	Correction factor(dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Degree (deg.)	Height (cm)	Remark
1!	32.5198	42.78	-8.73	34.05	40.00	-5.95			peak
2	65.5727	46.82	-21.24	25.58	40.00	-14.42			peak
3	127.6645	45.99	-14.19	31.80	40.00	-8.20			peak
4	226.0994	41.72	-15.72	26.00	40.00	-14.00			peak
5	360.4477	43.61	-11.61	32.00	47.00	-15.00			peak
6*	962.1623	45.70	-2.09	43.61	47.00	-3.39			peak



## 7. HARMONIC CURRENT EMISSION TEST

### 7.1. Test Standard and Limit

#### 7.1.1. Test Standard

EN61000-3-2: 2014

#### 7.1.2. Limits

Harmonic Current Test Limit (Class A)

Harmonic order (n)	Maximum permissible harmonic current (A)
Odd harmonics	
3	2.30
5	1.14
7	0.77
9	0.40
11	0.33
13	0.21
$15 \leq n \leq$	$0.15 \times 15/n$
Even harmonics	
2	1.08
4	0.43
6	0.30
$8 \leq n \leq$	$0.23 \times 8/n$

### 7.2. Test Procedure

The power cord of the EUT is connected to the output of the test system. Turn on the Power of the EUT and use the test system to test the harmonic current level.

### 7.3. Test Data

Note:

Not Applicable, Equipment with a rated power less than 75 W



## 8. VOLTAGE FLUCTUATION AND FLICKER TEST

### 8.1. Test Standard and Limit

#### 8.1.1. Test Standard

EN61000-3-3: 2013

#### 8.1.2. Limit

Flicker Test Limit

Test items	Limits
Pst	1.0
dc	3.3%
dmax	4.0%
dt	Not exceed 3.3% for 500ms

### 8.2. Test Procedure

The power cord of the EUT is connected to the output of the test system. Turn on the power of the EUT and use the test system to test the harmonic current level.

### 8.3. Test Data

#### Flicker Test Summary per EN/IEC61000-3-3 (Run time)

EUT: T20  
Test category: All parameters (European limits)  
Test date: 2019-05-05 Start time: 16:20:22 End time: 16:30:46  
Test duration (min): 10 Data file name: F-000023.cts\_data  
Comment: Keep Transmitting

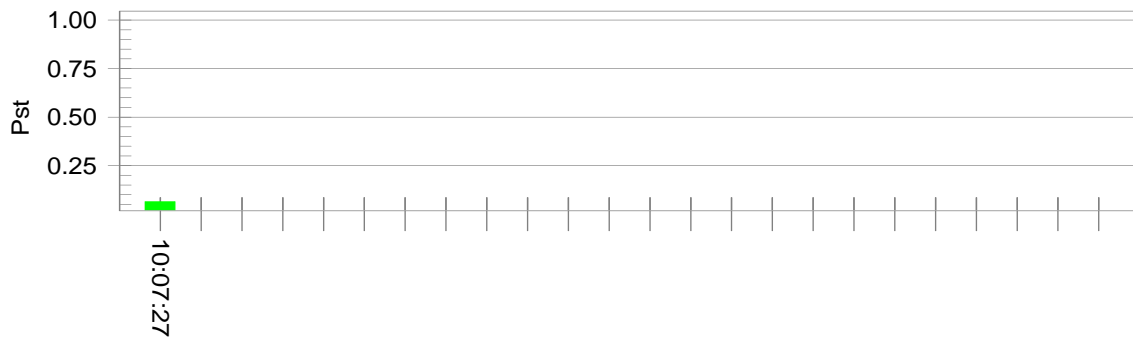
Tested by: Bill  
Test Margin: 100

Test Result: Pass

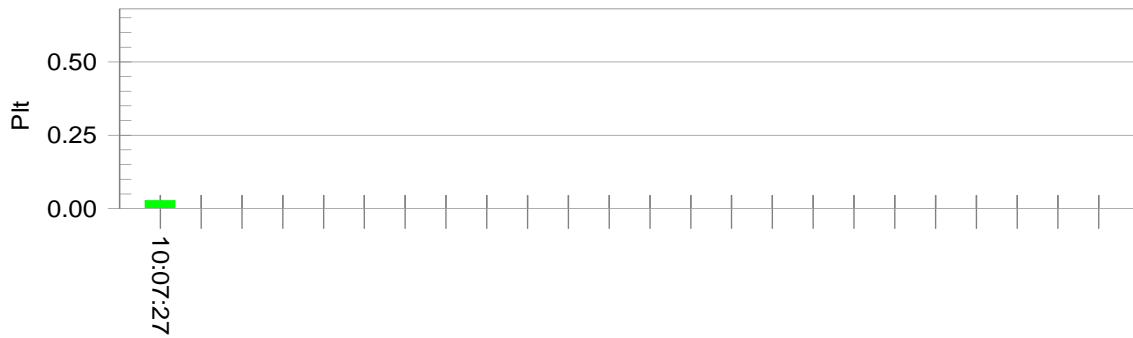
Status: Test Completed

Pst<sub>i</sub> and limit line

European Limits



**Plt and limit line**



**Parameter values recorded during the test:**

Vrms at the end of test (Volt):230.20

Highest dt (%):	-0.16	Test limit (%):	3.30	Pass
Time(mS) > dt:	0.0	Test limit (mS):	500.0	Pass
Highest dc (%):	0.00	Test limit (%):	3.30	Pass
Highest dmax (%):	-0.15	Test limit (%):	4.00	Pass
Highest Pst (10 min. period):	0.062	Test limit:	1.000	Pass
Highest Plt (2 hr. period):	0.022	Test limit:	0.650	Pass

## 9. ELECTROSTATIC DISCHARGE IMMUNITY TEST

### 9.1. Test Requirements

#### 9.1.1. Test Standard

EN 61000-4-2: 2009

#### 9.1.2. Test Level

Test Level for ESD Immunity Test

Port	Test Specification
Enclosure Port	8kV air discharge 4kV contact discharge

#### 9.1.3. Performance criterion: B

### 9.2. Test Procedure

#### 9.2.1. Contact Discharge:

The ESD generator is held perpendicular to the surface to which the discharge is applied and the tip of the discharge electrode touch the surface of EUT. Then turn the discharge switch. The generator is then re-triggered for a new single discharge and repeated 10 times for each pre-selected test point. This procedure shall be repeated until all the air discharge completed.

#### 9.2.2. Air Discharge:

Air discharge is used where contact discharge can't be applied. The round discharge tip of the discharge electrode shall be approached as fast as possible to touch the EUT. After each discharge, the discharge electrode shall be removed from the EUT. The generator is then re-triggered for a new single discharge and repeated 10 times for each pre-selected test point. This procedure shall be repeated until all the air discharge completed.

#### 9.2.3. Indirect discharge for horizontal coupling plane

At least 10 single discharges shall be applied to the horizontal coupling plane, at points on each side of the EUT.

#### 9.2.4. Indirect discharge for vertical coupling plane

At least 10 single discharges shall be applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5m X 0.5m, is placed parallel to, and positioned at a distance of 0.1m from the EUT. Discharges shall be applied to the coupling plane, with this plane in sufficient different positions that the four faces of the EUT are completely illuminated.



### 9.3. Test Data

#### ESD Immunity Test Data

Location	Voltage(kV)	Amount of test points	Discharge Method	Results
Slots	$\pm 2, \pm 4, \pm 8$	10	A	Pass
Enclosure	$\pm 2, \pm 4, \pm 8$	10	A	Pass
VCP	$\pm 2, \pm 4$	8	C	Pass
HCP	$\pm 2, \pm 4$	8	C	Pass

## 10. RADIATED ELECTROMAGNETIC FIELD IMMUNITY TEST

### 10.1. Test Requirements

#### 10.1.1. Test Standard

EN 61000-4-3: 2006+A2: 2010

#### 10.1.2. Test Level

Test Level for Radiated Electromagnetic Field Immunity Test

Port	Test Specification
Enclosure Port	80-1000MHz, 1.4GHz-2.7GHz 3 V/m 80 % AM (1kHz)

#### 10.1.3. Performance criterion: A

### 10.2. Test Procedure

The EUT and its simulators are placed on a turn table which is 0.8 meter above ground. EUT is set 3 meter away from the transmitting antenna which is mounted on an antenna tower. Both horizontal and vertical polarizations of the antenna are set on test. Each of the four sides of EUT must be faced this transmitting antenna and measured individually .In order to judge the EUT performance.

### 10.3. Test Data

Radiated Electromagnetic Field Immunity Test Data

Frequency Rang (MHz)	80 MHz –1GHz, 1.4GHz-2.7GHz	
Field Strength (V/m)	3V/m	
Steps (%)	1%	
	Horizontal	Vertical
Front	Pass	Pass
Rear	Pass	Pass
Left	Pass	Pass
Right	Pass	Pass

## 11. ELECTRICAL FAST TRANSIENTS/BURSTS IMMUNITY TEST

### 11.1. Test Requirements

#### 11.1.1. Test Standard

EN 61000-4-4: 2012

#### 11.1.2. Level

Test Level for EFT Immunity Test

Port	Test Specification
AC Power input	1kV (peak) 5/50 ns Tr/Th 5kHz repetition frequency
Signal line	1kV (peak) 5/50 ns Tr/Th 5kHz repetition frequency

#### 11.1.3. Performance criterion: B

### 11.2. Test Procedure

#### 11.2.1. For AC mains power ports:

The EUT is connected to the power mains by using a coupling device, which couples the EFT interference signal to AC power lines. Both polarities of the test voltage should be applied during compliance test and the duration of the test is 1minute.

### 11.3. Test Data

EFT Test Data

Injected Line	Voltage (kV)	Test Time (s)	Injected Method	Result
L	+1	60	Direct	Pass
	-1	60	Direct	Pass
N	+1	60	Direct	Pass
	-1	60	Direct	Pass
L,N	+1	60	Direct	Pass
	-1	60	Direct	Pass

## 12. TRANSIENTS AND SURGES TEST

### 12.1. Test Requirements

#### 12.1.1. Test Standard

EN 61000-4-5: 2014

#### 12.1.2. Level

Test Level for Surge

Severity Level	Open-Circuit Test Voltage KV
1	0.5
2	1.0
3	2.0
4	4.0
*	Special

#### 12.1.3. Performance criterion: B

### 12.2. Test Procedure

Set up the EUT and test generator For line to line coupling mode, provide a 0.5KV 1.2/50us voltage surge (at open-circuit condition) and 8/20us current surge to EUT selected points.

At least 5 positive and 5 negative (polarity) tests with a maximum 1/min repetition rate are conducted during test. Different phase angles are done individually. Record the EUT operating situation during compliance test and decide the EUT immunity criterion for above each test.

### 12.3. Test Data

Surge Test Data

Injected Line	Wave Form	Voltage (kV)	Phase	Number of Pulse	Interval time	Result
L-N	1.2/50 $\mu$ s	+1.0	0° ,90° ,270°	15	60s	Pass
		-1.0	0° ,90° ,270°	15	60s	Pass



### 13. CONDUCTED IMMUNITY TEST

#### 13.1. Test Requirements

##### 13.1.1. Test Standard

EN 61000-4-6: 2014+AC: 2015

##### 13.1.2. Level

Test Level for Conducted Immunity

Port	Test Specification
Input and output AC power port	0.15MHz~80MHz 3V(r.m.s.) (unmodulated)

##### 13.1.3. Performance criterion: A

#### 13.2. Test Procedure

Set up the EUT, CDN and test generators as shown above. The test is performed with the generator contacted to each CDN in turn. The frequency range is swept from 150kHz to 230MHz, using the signal levels established during the setting process, and with the disturbance signal 80% amplitude modulated with a 1kHz sine wave.

#### 13.3. Test Data

Conducted Immunity Test Data

Frequency Range (MHz)	Injected Position	Strength	Result
0.15MHz ~ 230MHz	AC Lines	3V(rms), Unmodulated	Pass
Dwell time: 1s; Steps: 1%			

## 14. VOLTAGE DIPS AND INTERRUPTIONS IMMUNITY TEST

### 14.1. Test Requirements

#### 14.1.1. Test Standard

EN 61000-4-11: 2004

#### 14.1.2. Level

Test Level for Voltage Dips and Interruptions

Port	Environmental phenomenon	Voltage dip and short interruptions % U <sub>T</sub>	Cycle
Input AC power port	Voltage dips	0 %	0.5
		0 %	1
	Voltage interruptions	70 %	25
		0 %	250

### 14.2. Test Procedure

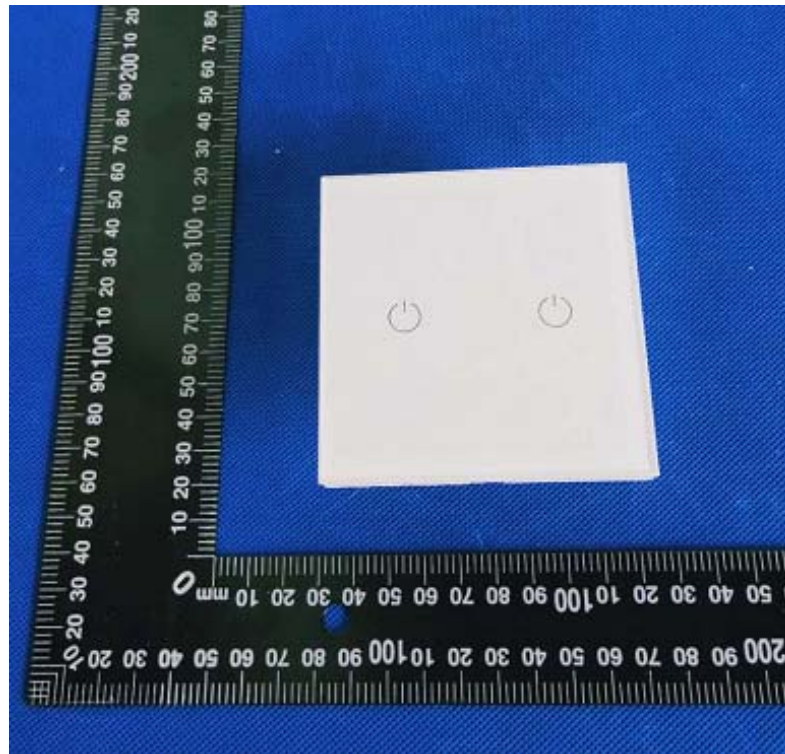
Refer to EN 61000-4-11

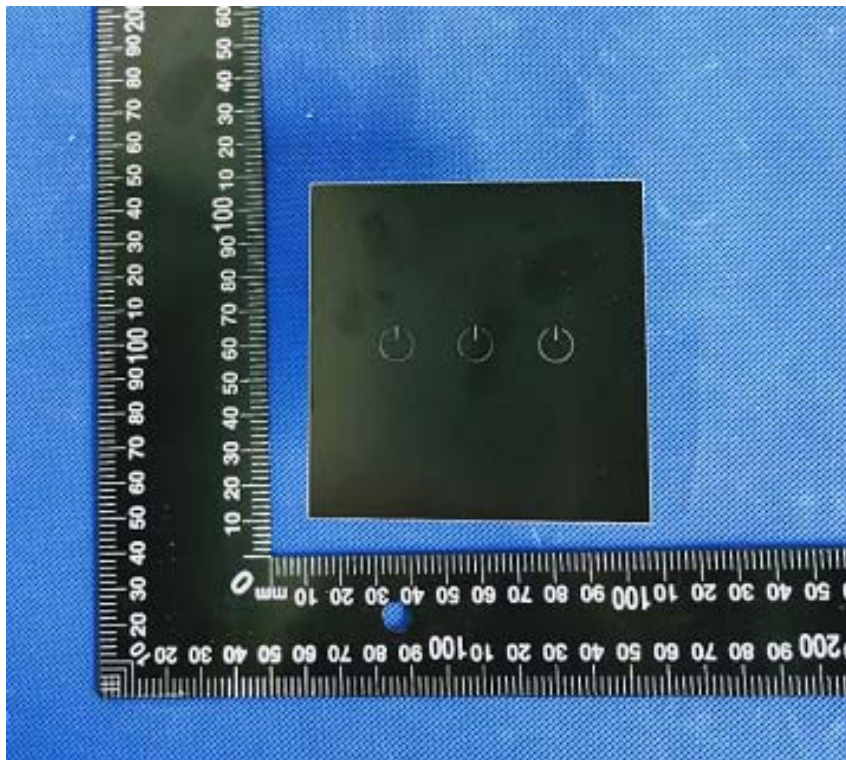
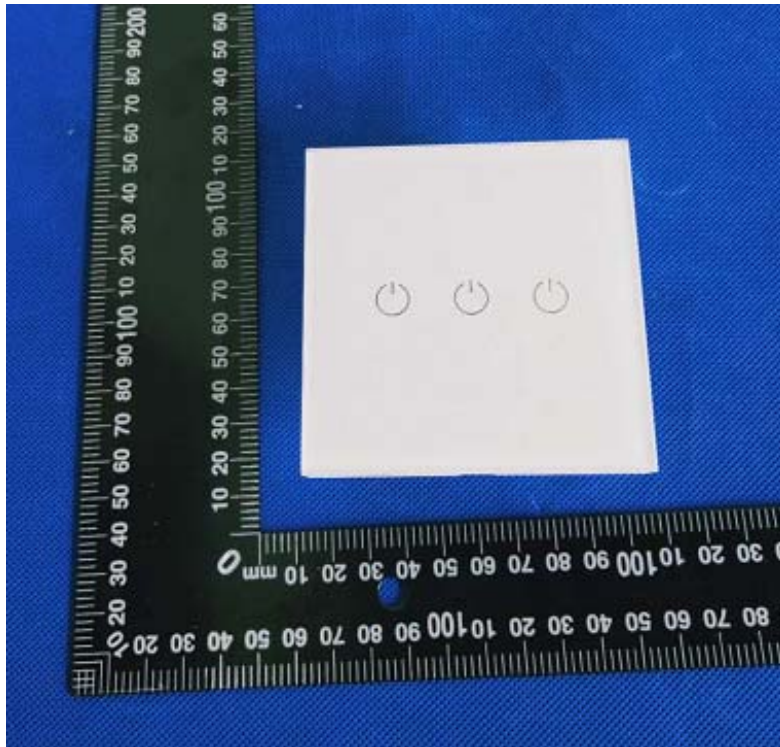
### 14.3. Test Data

Level	U <sub>2</sub>	T <sub>d</sub> (Periods)	Phase Angle	N	Result
1	0%	0.5	0/90/180/270	3	A
2	0%	1	0/90/180/270	3	A
3	70%	25	0/90/180/270	3	A
4	0%	250	0/90/180/270	3	B

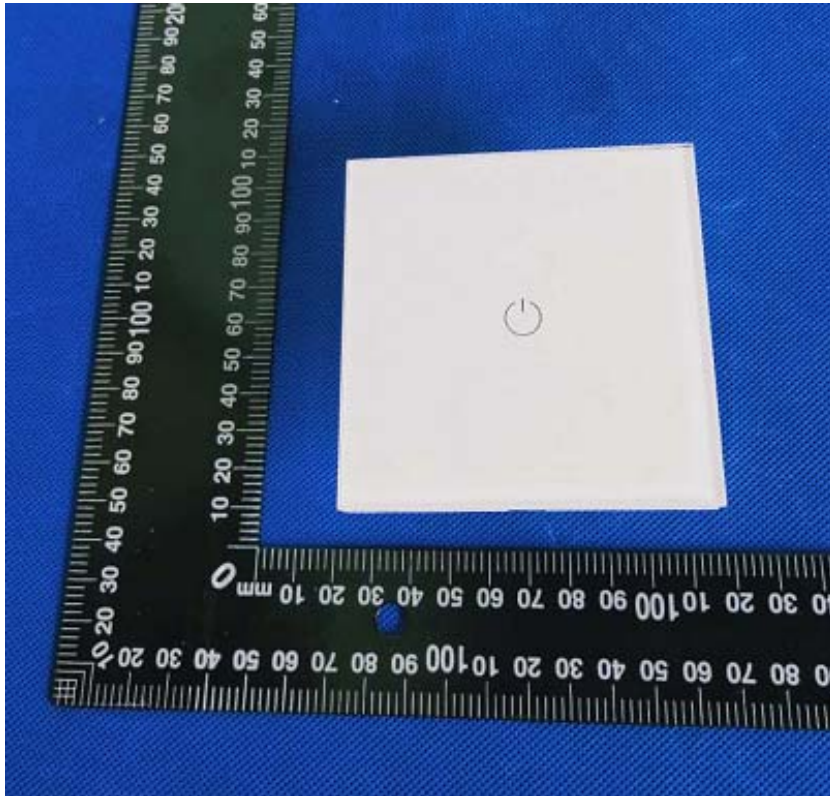


## APPENDIX I









\*\*\*End of the Report\*\*\*